



## High-rate growth of hydrogenated amorphous and microcrystalline silicon for thin-film silicon solar cells using dynamic very-high frequency plasma-enhanced chemical vapor deposition

Thomas Zimmermann

Forschungszentrum Jülich GmbH  
Institute of Energy- and Climate Research (IEK)  
Photovoltaics (IEK-5)

# **High-rate growth of hydrogenated amorphous and microcrystalline silicon for thin-film silicon solar cells using dynamic very-high frequency plasma-enhanced chemical vapor deposition**

Thomas Zimmermann

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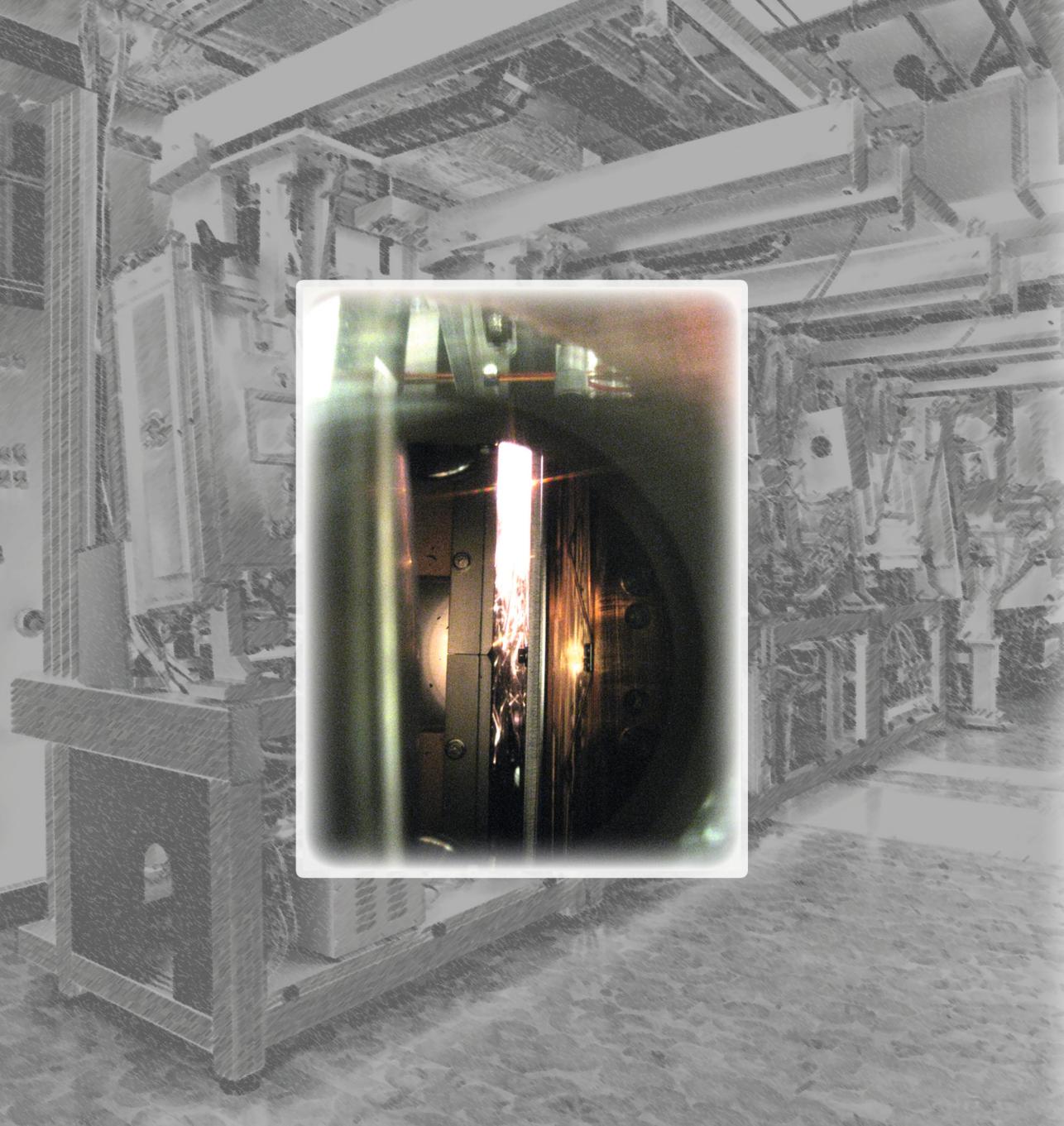
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